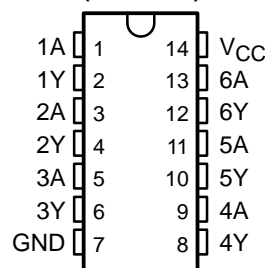


SN5407, SN5417, SN7407, SN7417 HEX BUFFERS/DRIVERS WITH OPEN-COLLECTOR HIGH-VOLTAGE OUTPUTS

SDLS032C – DECEMBER 1983 – REVISED JUNE 2001

- Convert TTL Voltage Levels to MOS Levels
- High Sink-Current Capability
- Input Clamping Diodes Simplify System Design
- Open-Collector Driver for Indicator Lamps and Relays
- Inputs Fully Compatible With Most TTL Circuits

SN5407, SN5417 . . . J OR W PACKAGE
SN7407 . . . D, N, OR NS PACKAGE
SN7417 . . . D OR N PACKAGE
(TOP VIEW)



description

These TTL hex buffers/drivers feature high-voltage open-collector outputs for interfacing with high-level circuits (such as MOS) or for driving high-current loads (such as lamps or relays), and also are characterized for use as buffers for driving TTL inputs. The SN5407 and SN7407 have minimum breakdown voltages of 30 V, and the SN5417 and SN7417 have minimum breakdown voltages of 15 V. The maximum sink current is 30 mA for the SN5407 and SN5417 and 40 mA for the SN7407 and SN7417.

These devices perform Boolean function $Y = A$ in positive logic.

These circuits are completely compatible with most TTL families. Inputs are diode clamped to minimize transmission-line effects, which simplifies design. Typical power dissipation is 145 mW, and average propagation delay time is 14 ns.

ORDERING INFORMATION

T _A	PACKAGE†		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
0°C to 70°C	SOIC – D	Tube	SN7407D	7407	
		Tape and reel	SN7407DR		
		Tube	SN7417D	7417	
		Tape and reel	SN7417DR		
	PDIP – N	Tube		SN7407N	SN7407N
				SN7417N	SN7417N
	SOP – NS	Tape and reel	SN7407NSR	SN7407	
–55°C to 125°C	CDIP – J	Tube	SNJ5407J	SNJ5407J	
			SNJ5417J	SNJ5417J	
	CFP – W	Tube	SNJ5407W	SNJ5407W	
			SNJ5417W	SNJ5417W	

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

logic diagram, each buffer/driver (positive logic)



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

 **TEXAS
INSTRUMENTS**

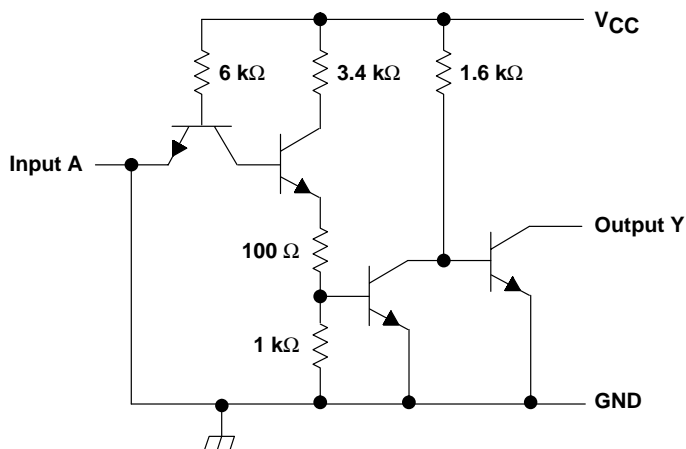
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SN5407, SN5417, SN7407, SN7417 HEX BUFFERS/DRIVERS WITH OPEN-COLLECTOR HIGH-VOLTAGE OUTPUTS

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schematic



Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	0.5 V to 7 V
Input voltage range, V_I (see Note 1)	0.5 V to 5.5 V
Output voltage, V_O (see Notes 1 and 2): SN5407, SN7407	30 V
SN5417, SN7417	15 V
Package thermal impedance, θ_{JA} (see Note 3): D package	86°C/W
N package	80°C/W
NS package	76°C/W
Storage temperature range, T_{Stg}	-65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values are with respect to GND.
2. This is the maximum voltage that should be applied to any output when it is in the off state.
3. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC} Supply voltage	SN5407, SN5417	4.5	5	5.5	V
	SN7407, SN7417	4.75	5	5.25	
V_{IH} High-level input voltage		2			V
V_{IL} Low-level input voltage				0.8	V
V_{OH} High-level output voltage	SN5407, SN7407			30	V
	SN5417, SN7417			15	
I_{OL} Low-level output current	SN5407, SN5417			30	mA
	SN7407, SN7417			40	
T_A Operating free-air temperature	SN5407, SN5417	-55		125	°C
	SN7407, SN7417	0		70	

SN5407, SN5417, SN7407, SN7417
HEX BUFFERS/DRIVERS
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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		MIN	TYP‡	MAX	UNIT
V_{IK}	$V_{CC} = \text{MIN}$,	$I_I = -12 \text{ mA}$			-1.5	V
I_{OH}	$V_{CC} = \text{MIN}$,	$V_{IL} = 0.8 \text{ V}$	$V_{OH} = 30 \text{ V}$ (SN5407, SN7407)		0.25	mA
			$V_{OH} = 15 \text{ V}$ (SN5417, SN7417)		0.25	
V_{OL}	$V_{CC} = \text{MIN}$,	$V_{IH} = 2 \text{ V}$	$I_{OL} = 16 \text{ mA}$		0.4	V
			$I_{OL} = 30 \text{ mA}$ (SN5407, SN5417)		0.7	
			$I_{OL} = 40 \text{ mA}$ (SN7407, SN7417)		0.7	
I_I	$V_{CC} = \text{MAX}$,	$V_I = 5.5 \text{ V}$			1	mA
I_{IH}	$V_{CC} = \text{MAX}$,	$V_{IH} = 2.4 \text{ V}$			40	μA
I_{IL}	$V_{CC} = \text{MAX}$,	$V_{IL} = 0.4 \text{ V}$			-1.6	mA
I_{CCH}	$V_{CC} = \text{MAX}$			29	41	mA
I_{CCL}	$V_{CC} = \text{MAX}$			21	30	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	A	Y	$R_L = 110 \Omega$, $C_L = 15 \text{ pF}$		6	10	ns
t_{PHL}					20	30	
t_{PLH}	A	Y	$R_L = 150 \Omega$, $C_L = 50 \text{ pF}$			15	ns
t_{PHL}						26	

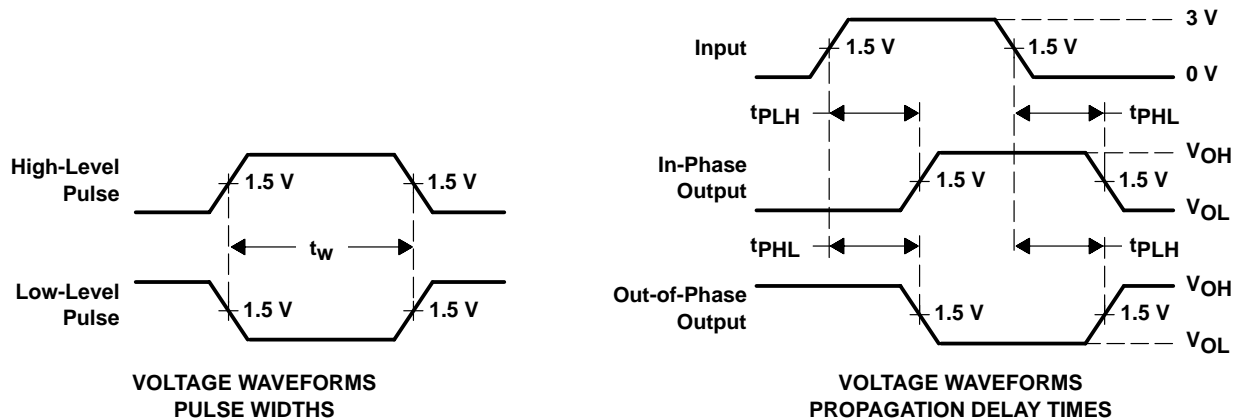
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PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT



- NOTES: A. C_L includes probe and jig capacitance.
 B. In the examples above, the phase relationships between inputs and outputs have been chosen arbitrarily.
 C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1$ MHz, $Z_O = 50 \Omega$, $t_r \leq 7$ ns, $t_f \leq 7$ ns.
 D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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